IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of: Kenji WATANABE et al.

Group Art Unit: 2881

Serial Number: 10/543,151

Examiner: Not yet assigned

Filed: April 18, 2006

Confirmation Number: 2634

For:

MAPPING-PROJECTION-TYPE ELECTRON BEAM APPARATUS FOR

INSPECTING SAMPLE BY USING ELECTRONS EMITTED FROM

THE SAMPLE

Attorney Docket Number: 052886

Customer Number: 38834

SECOND REQUEST FOR CORRECTED FILING RECEIPT

Mail Stop: Missing Parts Commissioner for Patents

P. O. Box 1450

October 3, 2006

Alexandria, VA 22313-1450

Sir:

Please supply the undersigned attorney with a corrected filing receipt for the aboveidentified application. The undersigned also respectfully requests that the Patent and Trademark Office records be amended to reflect the correction.

In reviewing the Official Filing Receipt, we noted an error in the First Assignee's Information. The First Assignee's Information should read -- EBARA CORPORATION, Tokyo, JAPAN--. A copy of the Supplemental Application Data Sheet is enclosed which indicates the correct information.

Second Request for Corrected Filing Receipt 10/543,151 Page 2

If any fees are required in connection with this paper, please charge Deposit Account No. 50-2866.

Respectfully submitted,

WESTERMAN, HATTOMI, DANIELS & ADRIAN, LLP

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SGA/if

Enclosures: Supplemental Application Data Sheet